

Application Note 410000059-B

Characterization of carbon materials with Raman spectroscopy

Following the guidelines of ASTM E3220

Carbon nanomaterials such as graphene, graphite, and carbon nanotubes each have unique physical and thermal properties that make them important in industries as varied as battery manufacturing, construction, and sports equipment. The necessity for simple, safe, and robust characterization of these materials grows as they are more widely used in manufacturing settings. Raman spectroscopy is a valuable tool for the characterization of carbon nanomaterials due to its selectivity, speed, and ability to measure samples nondestructively. Carbon materials typically exhibit simple Raman spectra, but they contain a wealth of information about internal microcrystalline structures in peak position, shape, and relative intensity.



INTRODUCTION

Raman spectra of graphene-based materials, like those in **Figure 1**, are characterized by three

major peaks: the G-band, the D-band, and the 2D-band.



carbon black (amorphous)



monolayer

graphene



nanotubes

graphite

Figure 1. Structure of different carbon allotropes.

The G-band appears near 1580 cm⁻¹ and represents the in-plane bending motion of doubly bonded carbon atoms. In high-quality graphene, the G-band is very sharp, indicating a high degree of crystallinity. The position of the G-band is sensitive to the number of graphene layers but is independent of laser excitation.

The D-band indicates disorder within a graphene sample. This band arises from a ring breathing mode for doubly bonded carbon atoms. In pristine graphene, the D-band is not

visible. The D-band is observed when there is a defect in the graphene, or the mode is close to an edge. The D-band exhibits dispersive behavior, meaning that it is sensitive to the laser excitation wavelength used in the experiment. The 2D-band is an overtone of the D-band, and the peak shape of the 2D-band can be used to determine layer thickness. Like the D-band, the 2D-band is dispersive and will change slightly with laser excitation.

RAMAN SPECTRA OF CARBON NANOMATERIALS

If the D-band represents the degree of disorder and the G-band represents the level of structural order, then the calculated ratio of D- and Gband intensities (I_D/I_G) can be used as a semiquantitative parameter to determine the quality of a graphene sample. As structural disorder within a sample increases, I_D/I_G increases. This parameter represents a quick quality control check that can be used as a Pass/Fail test in manufacturing settings. **Figure 2** shows Raman spectra from different carbon nanomaterials. Pristine graphene (red) contains only G- and 2D-bands; there is no D-band. The ratio of the intensity of the 2D-band and the intensity of the G- band (I_{2D}/I_G) 2. Graphite (green spectrum) is characterized by a widened and asymmetrical 2D-band, and the I_{2D}/I_G ratio is much lower. Carbon nanotubes (black spectrum), which are rolled up tubes of graphene, exhibit a slightly split G-band [1].



The curvature of single-walled carbon nanotubes splits the G-band into two degenerate modes: G+ and G-. Carbon black (blue spectrum), which has the least structural order, exhibits a strong D-band, and therefore has a high I_D/I_G . Note that laser excitement at a wavelength other than 532 nm will cause the slight shifts in the position of the D-band and 2D-band, due to their dispersive nature.



Figure 2. Raman spectra of graphene (red), carbon nanotubes (black), graphite (green), and carbon black (blue).

EXPERIMENT

An i-Raman[®] Prime 532H system was used for all measurements of graphene-based materials. The system has a 532 nm laser, which is the laser wavelength commonly chosen for Raman measurement of carbon. The i-Raman Prime is a low-noise, high-throughput, fully integrated Raman system with an embedded tablet computer.

A probe holder (BAC150B) was used for all measurements to support the fiber optic probe. An enclosure system (BAC152C) is available to achieve class 1 laser safety for a manufacturing floor. Typical laser power used is ~34 mW and acquisition times range from 30–90 s.

Table 1. Experimental parameters.

Equipment	Acquisition settings	
i-Raman Prime 532H	Laser Power	100%
Probe holder (BAC150)	Int. time	30–90s
BWSpec Software	Average	1

Determination of I_D/I_G

Guidelines for calculating I_D/I_G are documented in ASTM E3220 Standard Guide for Characterization of Graphene Flakes [2]. Spectra undergo baseline correction prior to peak intensity determination. For the spectra in **Figure 3**, a baseline removal algorithm was applied to data in the BWSpec software. The sharp peaks at ~1550 cm⁻¹ and ~2300 cm⁻¹ are attributed to atmospheric oxygen and nitrogen, respectively.



After baseline removal, peak intensities of spectral D- and G-bands are measured and I_D/I_G can be calculated. The software can be configured to automatically report I_D , I_G , and

derived I_D/I_G from a collected spectrum. The results can be easily exported to a report. **Table 2** shows the table that is generated in the software.

Source	D-band	G-band	D/G
a	2786.3214	1780.7942	0.7166
b	2184.0956	3037.7693	0.7190
с	851.1320	1457.8104	0.5838
d	1318.5770	2123.2700	0.6210
е	5179.8889	3289.7727	1.5745
f	2786.3214	5583.2101	0.4991

Table 2. Measured ID, IG, and calculated ID/IG from BWSpec software. Data sources align with those in Figure 2.

In **Figure 3**, nanofiber spectra are characterized by asymmetry in the G-bands. The I_D/I_G of spectrum (a) is particularly high, indicating that there is a high degree of structural disorder within that nanofiber sample.

The spectra from the carbon black samples (c–f) are categorized by broad D-bands and G-bands,

indicating very low crystallinity within the samples. Measured I_D/I_G for the carbon black samples are all above 0.5, indicating structural disorder within the sample. I_D/I_G can be used as a quick offline or atline quality control test of manufactured graphene, graphite, carbon nanotubes, and carbon black powder.





Figure 3. Raman spectra of carbon nanofibers (a,b) and carbon black powders (c–f). The insert shows an example of the baseline correction that was applied to all data. All spectra are manually offset for clarification.

CONCLUSION

Raman spectroscopy is a valuable technique for characterization of carbon nanomaterials. Carbon spectra are quite simple and often only characterized by three peaks.

The peak intensities, shapes, and positions reveal information about the internal crystallinity of the

sample. The ratio of the intensity of the D-band to the intensity of the G-band acts as a simple indicator of structural disorder or a sample. This I_D/I_G of a sample can be used by researchers and manufacturers to characterize their carbon nanomaterials.





REFERENCES

- Ferrari, A. C. Raman Spectroscopy of Graphene and Graphite: Disorder, Electron–Phonon Coupling, Doping and Nonadiabatic Effects. *Solid State Communications* 2007, *143* (1), 47–57. <u>https://doi.org/10.1016/j.ssc.2007.03.052</u>.
- ASTM International. Standard Guide for Characterization of Graphene Flakes; ASTM E3220-20; ASTM International, 2020.

CONTACT

メトロームジャパン株式会 社 143-0006 東京都大田区平 和島6-1-1 null 東京流通センター アネ ックス9階

metrohm.jp@metrohm.jp



CONFIGURATION



i-Raman Prime 532H

i-Raman[®] Prime 532H は、タフレット PC およひ光 ファイハーサンフルフローフ内蔵の、低ノイスかつ 高スルーフットの完全一体型のラマンシステムてす 。この携帯型ラマンスヘクトロメーターは、高い量 子効率、TE 冷却 (-25°C)、ならひに高いタイナミ ックレンシを備えた CCD アレイ検出器を使用し、 リアルタイムての定量化と同定を含む研究レヘルて のラマン分析を提供します。高スルーフットにより 、傑出した信号対雑音比のラマンスヘクトルを得る ことかてきるのて、速いフロセスの測定、およひ最 も弱いラマン信号てさえもか可能となり、サンフル の微細な相違も検出てきます。

i-Raman Prime 532Hには、その携帯式の構造に加 え、幅広いスヘクトル領域と高い分解能というユニ ークな組み合わせか装備されているため、150 cm⁻¹ から 3400 cm⁻¹まての測定か可能てす。i-Raman Prime はハッテリーての稼働か可能なのて、容易に 持ち運ひかてきます。そのため、場所を選はす、高 精度かつ質的、量的に価値の高いラマン分析を研究 レヘルて実施することかてきます。システムは、不 透明な ハッケーシ 越しの分析用の、弊社 STRaman[®]テクノロシーの使用向けに最適化されま した。

BWS475-532H-HT





BWSpec

BWSpec[®]は、リアルタイムによるヒークとトレン トの分析を含む装置のコントロール、テータ取得に 適したB&W Tekの分光法ソフトウェアてす。 BWSpecは、あらゆるB&W Tekホータフルラマン システムおよひスヘクトロメーター製品のこ購入時 に含まれる操作用ソフトウェアてす。広範囲なアフ リケーションのための機能を含み、ホタン1つて複 雑な測定およひ計算を行ないます。複数のテータ型 式に対応し、積分時間やレーサー出力コントロール 等、測定ハラメータを最適化するためのオフション か含まれています。テータ取得およひテータ処理に 加え、自動ターク除去、スヘクトルスムーシンク、 ヘースライン補正、ヒークモニタリンクおよひトレ ント分析といった各種機能を提供しています。

